Search Notes

Application/Control No.		Applicant(s)/Patent under Reexamination		
10/646,554		SCHOWTK	A, ALEXANDER K.	
Examiner		Art Unit		
Blake E. Betz		2672		

SEARCHED					
Class	Subclass	Date	Examiner		
345	619	2/2/2005	BB		
	620	2/1/2005	ВВ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
(image or picture or graphic or graph) same (fit or fix or suitable or suit) same (size or area or layout or position)	2/2/2005	ВВ
(image or picture or graphic or graph) with (size or area or layout) same limit and crop\$4	2/2/2005	ВВ
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